

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/796,154	<b>Applicant(s)/Patent under Reexamination</b> HAYASHI ET AL.
<b>Examiner</b> DUNG A. LE	<b>Art Unit</b> 2818	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner